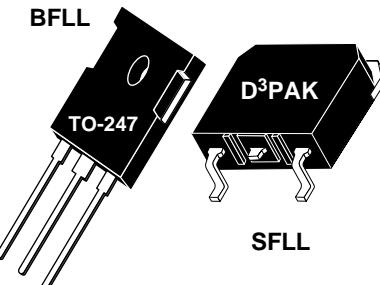


## POWER MOS 7™

**FRFDFET**

Power MOS 7™ is a new generation of low loss, high voltage, N-Channel enhancement mode power MOSFETS. Both conduction and switching losses are addressed with Power MOS 7™ by significantly lowering  $R_{DS(ON)}$  and  $Q_g$ . Power MOS 7™ combines lower conduction and switching losses along with exceptionally fast switching speeds inherent with APT's patented metal gate structure.



- Lower Input Capacitance
- Increased Power Dissipation
- Lower Miller Capacitance
- Easier To Drive
- Lower Gate Charge,  $Q_g$
- TO-247 or Surface Mount D³PAK Package
- **FAST RECOVERY BODY DIODE**

### MAXIMUM RATINGS

 All Ratings:  $T_C = 25^\circ\text{C}$  unless otherwise specified.

Symbol	Parameter	APT6029	UNIT
$V_{DSS}$	Drain-Source Voltage	600	Volts
$I_D$	Continuous Drain Current @ $T_C = 25^\circ\text{C}$	21	Amps
$I_{DM}$	Pulsed Drain Current ①	84	
$V_{GS}$	Gate-Source Voltage Continuous	$\pm 30$	Volts
$V_{GSM}$	Gate-Source Voltage Transient	$\pm 40$	
$P_D$	Total Power Dissipation @ $T_C = 25^\circ\text{C}$	300	Watts
	Linear Derating Factor	2.4	W/ $^\circ\text{C}$
$T_J, T_{STG}$	Operating and Storage Junction Temperature Range	-55 to 150	$^\circ\text{C}$
$T_L$	Lead Temperature: 0.063" from Case for 10 Sec.	300	
$I_{AR}$	Avalanche Current ① (Repetitive and Non-Repetitive)	21	Amps
$E_{AR}$	Repetitive Avalanche Energy ①	30	mJ
$E_{AS}$	Single Pulse Avalanche Energy ④	1210	

### STATIC ELECTRICAL CHARACTERISTICS

Symbol	Characteristic / Test Conditions	MIN	TYP	MAX	UNIT
$BV_{DSS}$	Drain-Source Breakdown Voltage ( $V_{GS} = 0\text{V}$ , $I_D = 250\mu\text{A}$ )	600			Volts
$I_{D(on)}$	On State Drain Current ② ( $V_{DS} > I_{D(on)} \times R_{DS(on)}$ Max, $V_{GS} = 10\text{V}$ )	21			Amps
$R_{DS(on)}$	Drain-Source On-State Resistance ② ( $V_{GS} = 10\text{V}$ , 0.5 $I_{D[Cont.]}$ )			0.290	Ohms
$I_{DSS}$	Zero Gate Voltage Drain Current ( $V_{DS} = V_{DSS}$ , $V_{GS} = 0\text{V}$ )			250	$\mu\text{A}$
	Zero Gate Voltage Drain Current ( $V_{DS} = 0.8 V_{DSS}$ , $V_{GS} = 0\text{V}$ , $T_C = 125^\circ\text{C}$ )			1000	
$I_{GSS}$	Gate-Source Leakage Current ( $V_{GS} = \pm 30\text{V}$ , $V_{DS} = 0\text{V}$ )			$\pm 100$	nA
$V_{GS(th)}$	Gate Threshold Voltage ( $V_{DS} = V_{GS}$ , $I_D = 1\text{mA}$ )	3		5	Volts

 CAUTION: These Devices are Sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.

 APT Website - <http://www.advancedpower.com>

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## DYNAMIC CHARACTERISTICS

APT6029 BFLL - SFLL

Symbol	Characteristic	Test Conditions	MIN	TYP	MAX	UNIT
$C_{iss}$	Input Capacitance	$V_{GS} = 0V$ $V_{DS} = 25V$ $f = 1\text{ MHz}$		2460		pF
$C_{oss}$	Output Capacitance			440		
$C_{rss}$	Reverse Transfer Capacitance			28		
$Q_g$	Total Gate Charge ③	$V_{GS} = 10V$ $V_{DD} = 0.5 V_{DSS}$ $I_D = I_D[\text{Cont.}] @ 25^\circ C$		56		nC
$Q_{gs}$	Gate-Source Charge			13		
$Q_{gd}$	Gate-Drain ("Miller") Charge			25		
$t_d(\text{on})$	Turn-on Delay Time	$V_{GS} = 15V$ $V_{DD} = 0.5 V_{DSS}$ $I_D = I_D[\text{Cont.}] @ 25^\circ C$ $R_G = 1.6\Omega$		13		ns
$t_r$	Rise Time			10		
$t_d(\text{off})$	Turn-off Delay Time			25		
$t_f$	Fall Time			8		

## SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS

Symbol	Characteristic / Test Conditions	MIN	TYP	MAX	UNIT
I <sub>S</sub>	Continuous Source Current (Body Diode)			21	Amps
I <sub>SM</sub>	Pulsed Source Current <sup>①</sup> (Body Diode)			84	
V <sub>SD</sub>	Diode Forward Voltage <sup>②</sup> ( $V_{GS} = 0V$ , $I_S = -I_D$ [Cont.])			1.3	Volts
dV/dt	Peak Diode Recovery dV/dt <sup>⑤</sup>			15	V/ns
t <sub>rr</sub>	Reverse Recovery Time ( $I_S = -I_D$ [Cont.], $dI/dt = 100A/\mu s$ )	T <sub>j</sub> = 25°C		250	ns
		T <sub>j</sub> = 125°C		515	
Q <sub>rr</sub>	Reverse Recovery Charge ( $I_S = -I_D$ [Cont.], $dI/dt = 100A/\mu s$ )	T <sub>j</sub> = 25°C	1.4		μC
		T <sub>j</sub> = 125°C	5.3		
I <sub>RRM</sub>	Peak Recovery Current ( $I_S = -I_D$ [Cont.], $dI/dt = 100A/\mu s$ )	T <sub>j</sub> = 25°C	13		Amps
		T <sub>j</sub> = 125°C	22		

## **THERMAL CHARACTERISTICS**

Symbol	Characteristic	MIN	TYP	MAX	UNIT
$R_{\theta JC}$	Junction to Case			0.42	°C/W
$R_{\theta JA}$	Junction to Ambient			40	

① Repetitive Rating: Pulse width limited by maximum junction temperature.

② Pulse Test: Pulse width < 380  $\mu$ s, Duty Cycle < 2%

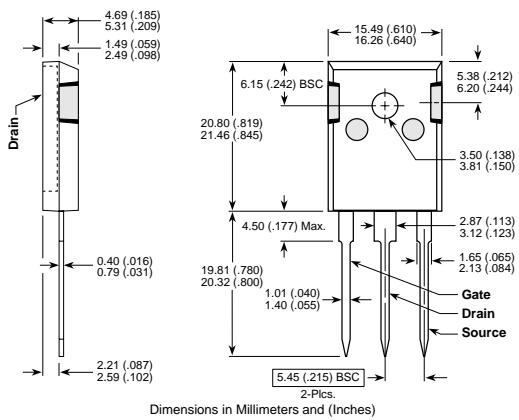
③ See MIL-STD-750 Method 3471

④ Starting  $T_i = +25^\circ\text{C}$ ,  $L = 5.49\text{mH}$ ,  $R_G = 25\Omega$ , Peak  $I_p = 21\text{A}$

⑤  $\frac{dv}{dt}$  numbers reflect the limitations of the test circuit rather than the device itself.  $I_S = -I_{D[Cont,1]}$   $\frac{di}{dt} \leq 700\text{A}/\mu\text{s}$   $V_R \leq V_{DSS}$   $T_J \leq 150^\circ\text{C}$

**APT Reserves the right to change, without notice, the specifications and information contained herein.**

## TO-247 Package Outline



D<sup>3</sup>PAK Package Outline

